

PATENT APPLICATION

THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of

Minoru KATAYAMA et al.

Group Art Unit: 2856

Application No.: 09/690,590

Examiner:

M. Cygan,

Filed: October 18, 2000

Docket No.:

1076126

For:

SURFACE TEXTURE MEASURING MACHINE, LEVELING DEVICE FOR

SURFACE TEXTURE MEASURING MACHINE AND ORIENTATION? ADJ

METHOD OF WORKPIECE OF SURFACE TEXTURE MEASURING ME

AMENDMENT UNDER 37 C.F.R. §1.111

Director of the U.S. Patent and Trademark Office Washington, D.C. 20231

Sir:

In reply to the Office Action mailed December 13, 2001, please amend the aboveidentified application as follows:

IN THE SPECIFICATION:

Page 10, lines 18-29, delete current paragraph and insert therefore:

A workpiece orientation adjustment stage 10 is provided on the base 11, the workpiece orientation adjustment stage 10 having a Y-axis stage 12 capable of moving in Y-axis direction (a direction orthogonal with X-axis direction [measurement direction] on a horizontal plane), a R-axis stage 13 provided on the Y-axis stage 12 and being capable of seesawing in R-axis direction (a direction orthogonal with the X-axis direction on a perpendicular plane), and a rotary stage 14 provided on the R-axis stage 13 and being rotatable in θ direction. Further, a column 15 stands on a right side of the rear of the base 11 as illustrated, the column 15 having a Z-axis slider 16 vertically movable along Z-axis

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